

## Measurement of the Surface Area of Silicon Carbide Suspensions using the Acorn Area™

## By Dr. David Fairhurst

Silicon carbide (carborundum) is an artificial mineral of composition SiC, typically manufactured by fusing sand and coke. It is an extremely hard material (Mohs hardness: 9/Knoop hardness: 2500), second only to diamond. SiC is used as an abrasive (as loose powder, coated abrasive cloth/paper and discs/wheels), as a reinforcement in aluminum-alloy composites and as a refractory (it can withstand temperatures up to 2300°C, has low thermal expansion and its heat conductivity is 10 times that of fireclay) in non-ferrous metallurgy and ceramics.

Particles of SiC are harder than those of aluminum oxide (another abrasive material) and, since they fracture less easily, are more suited for cutting, drilling and grinding hard cast irons and ceramics. However, unlike aluminum oxide, the crystals of SiC are large and need to be reduced in size (i.e., ground via crushing and ball-milling) to make the small grain (particle) size necessary for use as an abrasive. The efficiency and performance of abrasives is related to the specific grain size. SiC is ground as a concentrated wet suspension, an energy intensive, time consuming process that invariably results in the presence of fines that adversely impact abrasive performance and yield.

Surface area measurements are exquisitely sensitive to the presence of fines. As the particle size of a material is reduced, the surface area increases in proportion to the particle diameter<sup>2</sup>. Consequently, the surface area-to-volume ratio of the particles increases dramatically. For example reducing the particle diameter from 10 microns to 1 micron increases the surface area/gram by a factor of 100. This is an essential characteristic common to all particulate suspensions. It matters little what the particle shape is - the surface area per mass of any colloid is orders of magnitude larger than it is for particles of even only a few micrometers in size<sup>1</sup>. Measurement of the surface area is commonly determined using BET (N<sub>2</sub>) gas adsorption but requires the material under test to be a dry powder. However, drying wet suspensions inevitably results in aggregates and agglomerates and, as a consequence, the subsequent surface area measured by gas adsorption will be seriously underestimated. For wet suspensions of particles it is essential, then, that the surface area is measured directly.

## The Acorn Area<sup>™</sup>

The Acorn Area uses a patented technique based on NMR relaxation to determine the wetted surface area of suspensions of particulate materials such

<sup>&</sup>lt;sup>1</sup>D.H. Everett, "Basic Principles of Colloid Science", *RSC Publications*, London (1988)



as silicon carbide<sup>2</sup>. The Acorn Area takes advantage of the fact that liquid that is bound to a particle surface has a much smaller relaxation time than the free or bulk liquid. Thus a sample with a high surface area will have a smaller total relaxation time than a low surface area sample because there should be more of the fluid bound to the surface. In contrast to measurement of particle size by dynamic light scattering, where the raw intensity data has to be deconvoluted by means of complex algorithms, the NMR relaxation time can be converted into the absolute surface area by means of a straightforward calculation. As in the BET gas adsorption method, monolayer coverage of fluid onto the particle surface is assumed.

The most common method of surface area determination is nitrogen ( $N_2$ ) gas adsorption<sup>3,4</sup>. In this method,  $N_2$  is adsorbed on a sample kept at liquid  $N_2$  temperature at a series of different pressures. It is useful only for dry powders and requires that the sample be degassed to drive off any adsorbed material (sample conditioning); this requires a source of liquid  $N_2$  to maintain the proper sample temperature; and this is also a critical experimental requirement<sup>5</sup>.

It is possible to calculate the surface area from measurements of the particle size but it assumes spherical particles and a monodisperse size distribution, a condition clearly not met by SiC materials. Any surface area calculated for such materials is, at best, only a crude approximation; it is well-recognized that particle shape, surface irregularities and porosity will inevitably lead to estimated values significantly less than the true value<sup>6</sup>.

In contrast, the Acorn Area measures suspensions directly and requires no sample pretreatment or temperature control. There are no assumptions about the sample particle size (distribution) or shape used in the determination of surface area; it is measured directly. Thus, it is, inherently, a much simpler measurement technique; and as little as 0.5 ml of sample is needed.

The formula for calculating the surface area from the measured NMR relaxation time is:

 $R_{av} = \Psi_p \mathbf{S} L \rho_p (R_s - R_b) + R_b$ 

(1)

<sup>&</sup>lt;sup>2</sup> US Patent, 7,417,426, August 26, 2008.

<sup>&</sup>lt;sup>3</sup> SJ. Gregg and KSW. Sing, "Adsorption, Surface Area and Porosity", 2<sup>nd</sup> Edition, Academic Press, London, 1982.

<sup>&</sup>lt;sup>4</sup> S. Lowell and J E. Shields, "Powder Surface Area and Porosity", Chapman Hall, London, 1984.

<sup>&</sup>lt;sup>5</sup> KSW. Sing, "The Use of Gas Adsorption for the Characterization of Porous Solids", *Colloids and Surfaces*, <u>38</u> 113 (1989).

<sup>&</sup>lt;sup>6</sup> T. Allen, "Particle Size Measurement", Chapman & Hall, 4<sup>th</sup> Edition, New York, 1990.



where  $R_{av}$  is the average spin relaxation rate constant,  $\psi_p$  is the particle volume to liquid volume ratio, **S** is the total surface area per unit weight, L is the surface layer thickness of liquid,  $\rho_b$  is the bulk particle density,  $R_s$  is the relaxation rate constant for the bound solvent and  $R_b$  is the relaxation rate constant for the free or bulk solvent.

Using a standard reference material we can define a constant,  $K_a = L \rho_b (R_s - R_b)$  so that the equation (1) reduces to:

$$R_{av} = K_a S \Psi_p + R_b$$

(2)

The surface area can then be calculated from:

$$\mathbf{S} = \mathbf{R}_{sp} \mathbf{R}_{b} / \mathbf{K}_{a} \mathbf{\Psi}_{p}$$

where,  $R_{sp} = R_{av}/R_b - 1$ 

A more precise method is to use the slope of a plot  $R_{sp}$  as a function of different volume ratios,  $\Psi_p$  (i.e. concentrations).

## **Results of Surface Area Measurements**

To demonstrate the applicability of the Acorn Area to the measurement of the surface area of SIC, we used a series of suspensions sampled as a function of milling time from a processing batch. The concentration of each suspension was approximately 50 wt%. Each suspension was measured three times (using a fresh aliquot from the bulk sampling) and the measured surface area averaged. The results summarized in Figure 1 illustrate the effect of milling time on surface area:





It can be clearly seen that, for this particular SiC material, milling beyond 48 hours is, as a result of overgrinding, counter-productive.

Given the economic implication of overgrinding, a direct measurement of the wetted surface area without dilution or other sample preparation is critical. This is now available for the first time with the Acorn Area.